Attorney Docket No. 1793.1052

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Kyung-geun Lee, et al.

Application No. 10/678,633 Group Art Unit: 2655

Confirmation No. 7810

Filed: October 6, 2003 Examiner: Tan X. Dinh

For: OPTICAL STORAGE MEDIUM HAVING TEST PATTERN FOR MEASURING A MODULATION DEGREE DURING RECORDING PROCESS

## STATEMENT OF SUBSTANCE OF INTERVIEW

Commissioner for Patents
PO Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with the Interview Summary reflecting the interview of July 26, 2007 with Mr. Howard Levy, a Statement of Substance for the interview must be filed. The substance of the interview was that the claims were compared to the applied prior art as indicated in the interview summary.

Respectfully submitted,

STEIN, MCEWEN & BUI, LLP

Dated: August 3, 2007

By: _____
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